### Gallium Nitride, 160W,2.0-3.5GHz RF Power Transistor Description

The GTAH30160D4 is a 160W 28V, both input and output matched GaN HEMT, ideal for multiple applications from 2.0-3.0GHz, and at higher voltage 32V, capable to output more than 200W.

#### It can support linear and saturated application, for both CW and pulsed CW.

There is no guarantee of performance when this part is used outside of stated frequencies.

• Typical performance across 2.0-3.0GHz class AB application circuit with device soldered Vds= 28V, Idq=100mA(Vgs=-2.7V) , CW

GTAH30160D4	Ļ

Freq(MHz)	Pin(dBm)	Pout(dBm)	Pout(W)	lds(A)	Gain(dB)	Eff(%)
2000	39.56	52.58	181.1	11.6	13.0	55.8
2100	39.79	52.76	188.8	12.5	13.0	53.9
2200	40.06	52.60	182.0	11.9	12.5	54.6
2300	39.79	52.54	179.5	11.6	12.8	55.3
2400	39.91	52.61	182.4	12.6	12.7	51.7
2500	39.73	52.83	191.9	12.7	13.1	54.0
2600	39.76	52.96	197.7	13.0	13.2	54.5
2700	38.95	52.75	188.4	12.6	13.8	53.6
2800	38.88	52.60	182.0	12.5	13.7	52.1
2900	39.20	52.50	177.8	12.7	13.3	50.0
3000	39.43	52.53	179.1	13.4	13.1	48.5

### Applications

- S band pulse power amplifier
- S band CW amplifier
- 5G wideband power amplifier

#### **Important Note: Proper Biasing Sequence for GaN HEMT Transistors**

#### Turning the device ON

- 1. Set VGS to the pinch--off (VP) voltage, typically -5 V
- 2. Turn on VDS to nominal supply voltage
- 3. Increase VGS until IDS current is attained
- 4. Apply RF input power to desired level

#### Turning the device OFF

- 1. Turn RF power off
- 2. Reduce VGS down to VP, typically -5 V
- 3. Reduce VDS down to 0 V
- 4. Turn off VGS

#### Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
DrainSource Voltage	V <sub>DSS</sub>	+150	Vdc
GateSource Voltage	V <sub>GS</sub>	-10 to +2	Vdc
Operating Voltage	V <sub>DD</sub>	32	Vdc

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		5		
Maximum gate current	lgs	43.2	mA	
Storage Temperature Range	Tstg	-65 to +150	°C	
Case Operating Temperature	Tc	+150	°C	
Operating Junction Temperature	TJ	+225	°C	
Table 2. Thermal Characteristics	· · · · ·			
Characteristic	Symbol	Value	Unit	
Thermal Resistance, Junction to Case by FEA	Date	0.4	00 MM	
T <sub>c</sub> = 85°C, at Pout=160W at 3.0GHz	Rejc	0.4	°C /W	

#### Table 3. Electrical Characteristics (TA = 25°C unless otherwise noted)

#### DC Characteristics (measured on wafer prior to packaging)

Characteristic	Conditions	Symbol	Min	Тур	Max	Unit
Drain-Source Breakdown Voltage	VGS=-8V; IDS=43.2mA	V <sub>DSS</sub>		150		V
Gate Threshold Voltage	VDS =10V, ID = 43.2mA	V <sub>GS(th)</sub>	-4		-2	V
Gate Quiescent Voltage	VDS =28V, IDS=80mA, Measured in Functional Test	V <sub>GS(Q)</sub>		-2.7		V

#### **Ruggedness Characteristics**

Characteristic	Conditions	Symbol	Min	Тур	Max	Unit
Load mismatch capability	3GHz, Pout=160W Pulsed CW					
	All phase,	VSWR		10:1		
	No device damages					

#### Figure 2: Median Lifetime vs. Channel Temperature

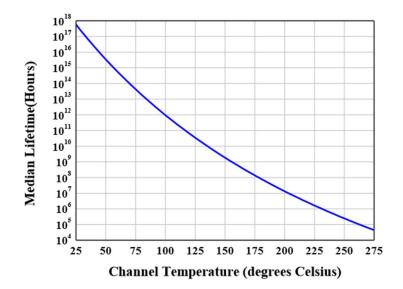


Figure 3 Network analyzer output, S11 and S21 (2.0-3.0GHz Class AB) Vds=28V, Idq=500mA

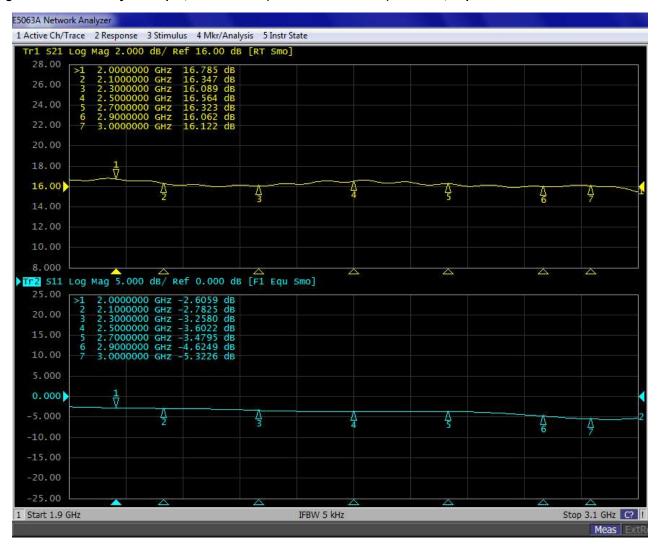
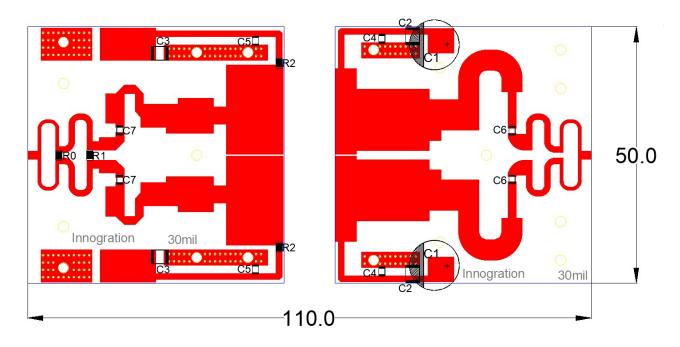


Figure 5: Picture of application board 2.0-3.0GHz class AB

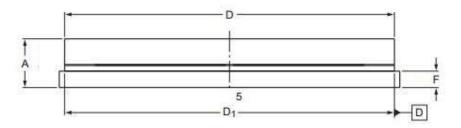


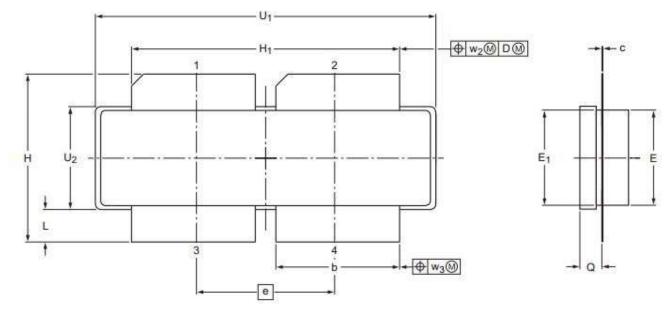
#### Table 4. Bill of materials of application board (PCB layout upon request)

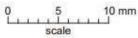
Component	Description	Suggestion
C1	470uF/63V	
C2, C3	10uF	1210
C4, C5, C6, C7	12pF	MQ300805
R0	Chip Resistor,100Ω	0805
R1	Chip Resistor,240Ω	1206
R2	Chip Resistor,10Ω	0805
РСВ	Rogers 4350B, thickness 30 mils, 1oz copper	

### Package Outline

Earless flanged ceramic package; 4 leads (1, 2—DRAIN, 3, 4—GATE, 5—SOURCE)







UNIT	Α	b	с	D	D1	е	Е	E1	F	н	H1	L	Q	U1	U <sub>2</sub>	W <sub>2</sub>	W <sub>2</sub>
	4.7	11.81	0.18	31.55	31.52	12 72	9.50	9.53	1.75	17.12	25.53	3.48	2.26	32.39	10.29	0.25	0.25
mm	4.2	11.56	0.10	30.94	30.96	13.72	9.30	9.27	1.50	16.10	25.27	2.97	2.01	32.13	10.03	0.25	0.25
inches	0.185	0.465	0.007	1.242	1.241	0.540	0.374	0.375	0.069	0.674	1.005	0.137	0.089	1.275	0.405	0.01	0.01
mulles	0.165	0.455	0.004	1.218	1.219	0.340	0.366	0.365	0.059	0.634	0.995	0.117	0.079	1.265	0.395	0.01	0.01

OUTLINE		REFERENCE		EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
PKG-D4					03/12/2013

### **Revision history**

#### Table 4. Document revision history

Date	Revision	Datasheet Status
2023/9/15	V1.0	Preliminary Datasheet Creation

Application data based on: YHG-23-22

#### Notice

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